

IRFBF20LPBF-VB Datasheet **Power MOSFET**

PRODUCT SUMMARY					
V _{DS} (V)	950	950			
R _{DS(on)} (Ω)	V _{GS} = 10 V	5.4			
Q _g (Max.) (nC)	78				
Q _{gs} (nC)	10				
Q _{gd} (nC)	42				
Configuration	Single				

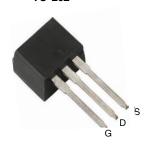
FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

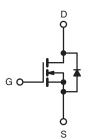




TO-262



Top View



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMITE	UNIT	
Drain-Source Voltage			V_{DS}	950	V	
Gate-Source Voltage			V_{GS}	± 20	7 v	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	I _D	3.6		
	VGS at 10 V	T _C = 100 °C		2.3	Α	
Pulsed Drain Current ^a			I _{DM}	14		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	250	mJ	
Repetitive Avalanche Currenta			I _{AR}	3.6	Α	
Repetitive Avalanche Energya			E _{AR}	13	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	125	W	
Peak Diode Recovery dV/dt ^c			dV/dt	1.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
oldering Recommendations (Peak Temperature) for 10 s			300 ^d	7		
Mounting Torque	6 22 or l	12 oorou		10	lbf ⋅ in	
Mounting Torque	6-32 or M3 screw			1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 36 mH, R_g = 25 Ω , I_{AS} = 3.6 A (see fig. 12). c. $I_{SD} \le 3.6$ A, dI/dt ≤ 70 A/µs, $V_{DD} \le 600$, $T_J \le 150$ °C.
- d. 1.6 mm from case.



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0			

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		950	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	1.1	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V	-	-	± 100	nA
Zava Cata Valtaga Drain Current		V _{DS} = 900 V, V _{GS} = 0 V		-	-	100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 720 V	V _{DS} = 720 V, V _{GS} = 0 V, T _J = 125 °C		-	500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 2.2 A ^b	_	5.4	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	100 V, I _D = 2.2 A ^b	2.3	-	-	S
Dynamic							
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,		1200	-	
Output Capacitance	C _{oss}	1	$V_{DS} = 25 \text{ V},$	-	320	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1	0 MHz, see fig. 5	-	200	-	
Total Gate Charge	Qg			-	-	78	nC
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V	$I_D = 3.6 \text{ A}, V_{DS} = 360 \text{ V},$ see fig. 6 and 13 ^b	-	-	10	
Gate-Drain Charge	Q _{gd}		See lig. 6 and 15		-	42	
Turn-On Delay Time	t _{d(on)}	$V_{DD}=450~\text{V, I}_D=3.6~\text{A,}$ $R_g=12~\Omega,~R_D=120~\Omega,~\text{see fig. }10^{\text{b}}$		-	14	-	- ns
Rise Time	t _r			-	25	-	
Turn-Off Delay Time	t _{d(off)}			-	90	-	
Fall Time	t _f			-	30	-	
Internal Drain Inductance	L_D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	-11
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-		3.6	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	14	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 3.6 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	=	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 3.6 A, dI/dt = 100 A/µs ^b		-	430	650	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.4	2.1	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

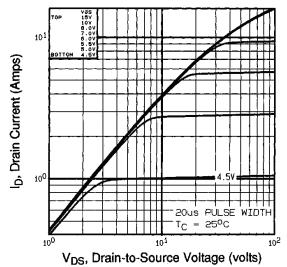


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

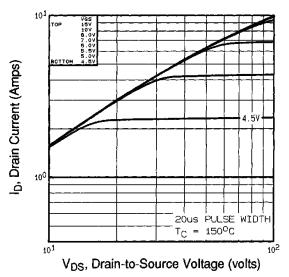
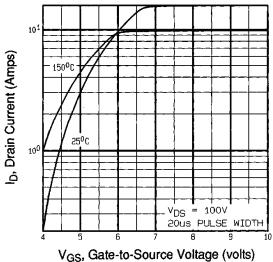


Fig. 2 -Typical Output Characteristics, $T_C = 150 \, ^{\circ}C$



VGS, Gate-to-Source Voltage (Volts)
Fig. 3 - Typical Transfer Characteristics

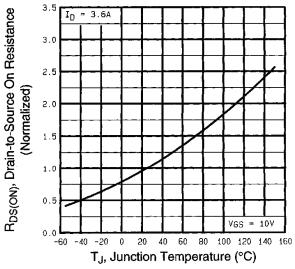


Fig. 4 - Normalized On-Resistance vs. Temperature



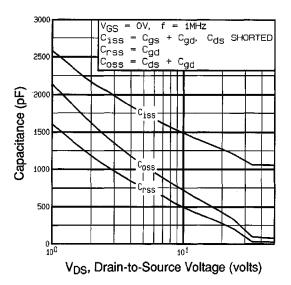
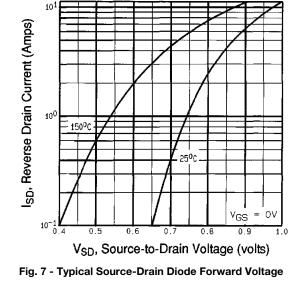


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



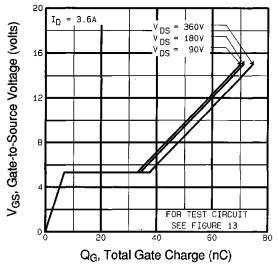


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

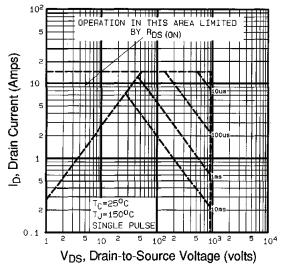


Fig. 8 - Maximum Safe Operating Area

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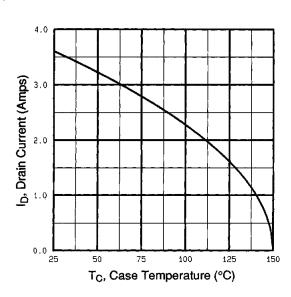


Fig. 9 - Maximum Drain Current vs. Case Temperature

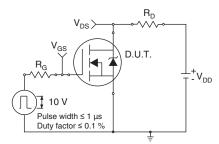


Fig. 10a - Switching Time Test Circuit

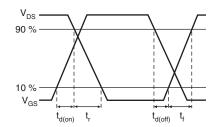


Fig. 10b - Switching Time Waveforms

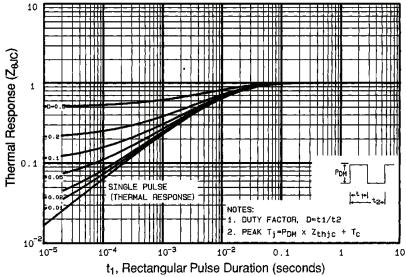


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

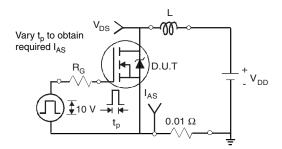


Fig. 12a - Unclamped Inductive Test Circuit

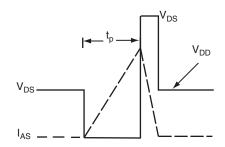


Fig. 12b - Unclamped Inductive Waveforms



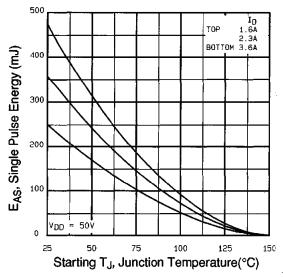


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

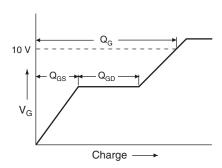


Fig. 13a - Basic Gate Charge Waveform

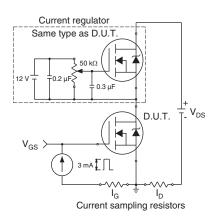
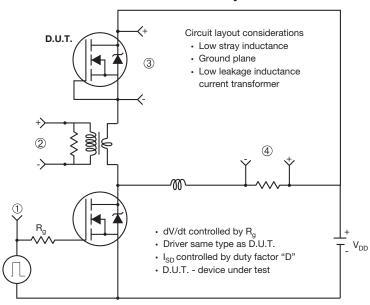


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



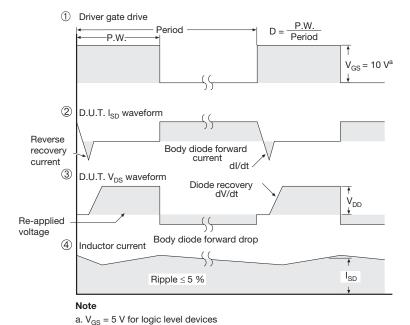
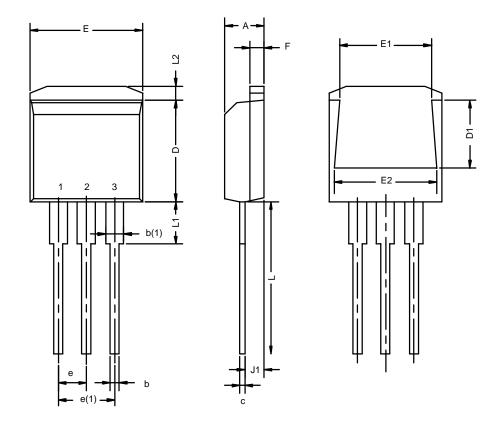


Fig. 14 - For N-Channel

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	MILLIM	ETERS*	INC	INCHES		
Dim	Min	Max	Min	Max		
Α	4.32	4.70	0.170	0.185		
b	0.64	1.00	0.025	0.039		
b(1)	1.14	1.40	0.045	0.055		
С	0.36	0.50	0.014	0.020		
D	8.64	9.65	0.340	0.380		
D1	5.59	6.10	0.220	0.240		
е	2.41	2.67	0.095	0.105		
e(1)	4.95	5.33	0.195	0.210		
E	10.03	10.41	0.395	0.410		
E1	7.87	8.64	0.310	0.340		
E2	9.02	9.53	0.355	0.375		
F	1.14	1.40	0.045	0.055		
J1	2.41	2.79	0.095	0.110		
L	13.08	14.22	0.515	0.560		
L1	-	3.81	-	0.150		
L2	1.02	1.40	0.040	0.055		
ECN: T-02234—Rev. C, 14-Oct-02 DWG: 5855						

^{*}Use millimeters as the primary measurement



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